



Certificate of Analysis

ULTRAgade™ Solution
Silver ICP Standard
10000 µg/mL

Catalog Number: ICP-147
Lot Number: R00116
Lot Issue Date: 02/13/2013
Expiration Date: 03/31/2020

Starting Material: Silver Nitrate (* light sensitive)
Starting Material Purity: 99.995%
Starting Material Lot No.: BH02426
Matrix: 2% nitric acid in low TOC water (< 50 ppb)
Atomic Weight Ag: 107.88

Certified Value: 10006 ± 20 µg/mL

This Certified Reference Material (CRM) was manufactured and verified in accordance with ULTRA's ISO 9001 registered quality system. The analyte concentrations were verified by our ISO 17025 accredited laboratory to be within ± 2.5%, when compared to calibration standards independently prepared using NIST SRM(s). The certified value and uncertainty value at the 95% confidence level for each analyte is determined gravimetrically.

Classical Wet Assay Method: Theoretical, based on gravimetric measurements

Confirmation by Inductively Coupled Plasma Spectroscopy (ICP / ICP-MS) vs. NIST SRM 3151

ULTRA uses purified acids, 18 megohm double deionized water, calibrated Class A glassware and clean bottles in the manufacture of ULTRAgade standards. Balances used in the manufacture of this standard are calibrated with weights traceable to NIST in compliance with ANSI/NCSL Z-540-1 and ISO 9001.

Trace Metallic Impurities in Solution Standard in µg/mL:

* Al <0.005 D	* Ga <0.005 ND	n Nb	* S <0.005 D
* Sb <0.005 ND	n Ge	n Os	n Ta
* As <0.005 ND	n Au	* Pd <0.005 ND	n Te
* Ba <0.005 D	n Hf	* P <0.005 ND	n Tb
* Be <0.005 ND	n Ho	* Pt <0.005 ND	* Tl <0.005 ND
* Bi <0.005 ND	* In <0.005 ND	* K <0.005 D	n Th
* B <0.005 D	n Ir	n Pr	n Tm
* Cd <0.005 ND	* Fe <0.005 D	n Re	* Sn <0.005 ND
* Ca <0.005 D	* La <0.005 ND	n Rh	* Ti <0.005 ND
n Ce	* Pb <0.005 D	n Rb	n W
n Cs	* Li <0.005 ND	n Ru	n U
* Cr <0.005 ND	n Lu	n Sm	* V <0.005 ND
* Co <0.005 ND	* Mg <0.005 D	n Sc	n Yb
* Cu <0.005 D	* Mn <0.005 ND	* Se <0.005 ND	n Y
n Dy	* Hg <0.005 ND	* Si <0.005 D	* Zn <0.005 D
* Er <0.005 ND	* Mo <0.005 ND	s Ag	n Zr
* Eu <0.005 ND	n Nd	* Na <0.005 D	
* Gd <0.005 ND	* Ni <0.005 D	* Sr <0.005 ND	

* - element checked for
ND - not detected
i - spectral interference
D - detected
n - not checked for
s - solution standard element

Density of Solution (measured at 20.00°C ± 0.05°C): 1.0215 g/mL



ISO 17025:2005
Accredited
A2LA
Cert. No. 0851.01

ISO 9001:2000
Registered
TUV USA, Inc.
Cert. No. 06-1004

William J. Leary
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